

Search Notes 				Application/Control No. 10/629,983 Examiner Anthony Weier		Applicant(s)/Patent under Reexamination LI, KE-YI Art Unit 1761	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner			DATE	EXMR
updated	previous search	1/4/2007	AW				
INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				